

10/072469



06/02

708 N P

U.S. UTILITY Patent Application

PATENT NUMBER and
ISSUE DATE

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10072469	02/06/2002	359	G39.000	2873	BEN

**APPLICANTS: Lange Steven;

**CONTINUING DATA VERIFIED:

THIS APPLICATION IS A CIP OF 09/602,920 06/23/2000 PAT 6,362,923 BEN 2873
WHICH CLAIMS BENEFIT OF 60/188,309 03/10/2000

BEST AVAILABLE COPY

** FOREIGN APPLICATIONS VERIFIED:

PG-PUB DO NOT PUBLISH ☐RESCIND ☐

Foreign priority claimed ☐ yes ☐ no
35 USC 119 conditions met ☐ yes ☐ no
Verified and Acknowledged Examiners's initials

ATTORNEY DOCKET NO
KLA1P027X1

TITLE : Multi-detector microscopic inspection system

U.S. DEPT. OF COMM./PAT. & TM.-PTO-436L (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		Assistant Examiner	CLAIMS ALLOWED		
			Total Claims	Print Claim for O.G.	
ISSUE FEE		Primary Examiner	DRAWING		
Amount Due	Date Paid		Sheet Drwg.	Fig. Drwg.	Print Fig.
<input type="checkbox"/> TERMINAL DISCLAIMER		PREPARED FOR ISSUE	Application Examiner		
WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.					

FILED WITH:

☐ DISK (CRF)☐ CD-ROM

(Attached in pocket on right inside flap)